







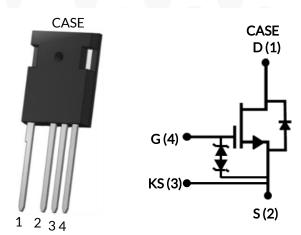








# UJ3C120070K4S



Part Number	Part Number Package	
UJ3C120070K4S	TO-247-4L	UJ3C120070K4S







### 1200V-70m $\Omega$ SiC FET

Rev. A, December 2021

### Description

The UJ3C120070K4S is a 1200V,  $70m\Omega$  G3 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

#### **Features**

- On-resistance  $R_{DS(on)}$ :  $70m\Omega$  (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q<sub>rr</sub> = 113nC
- ◆ Low body diode V<sub>FSD</sub>: 1.41V
- Low gate charge: Q<sub>G</sub> = 46nC
- ◆ Threshold voltage V<sub>G(th)</sub>: 5.0V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected: HBM class 2 and CDM class C3
- TO-247-4L package for faster switching, clean gate waveforms

### Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating















# Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	$V_{DS}$		1200	V
Gate-source voltage	$V_{GS}$	DC	-25 to +25	V
Continuous drain current <sup>1</sup>	I <sub>D</sub>	T <sub>C</sub> = 25°C	34.5	Α
Continuous drain current		T <sub>C</sub> = 100°C	25.5	Α
Pulsed drain current <sup>2</sup>	I <sub>DM</sub>	T <sub>C</sub> = 25°C	80	Α
Single pulsed avalanche energy <sup>3</sup>	E <sub>AS</sub>	L=15mH, I <sub>AS</sub> =2.8A	58.5	mJ
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25°C	254.2	W
Maximum junction temperature	$T_{J,max}$		175	°C
Operating and storage temperature	$T_J, T_{STG}$		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	T <sub>L</sub>		250	°C

- 1. Limited by  $T_{J,max}$
- 2. Pulse width  $t_p$  limited by  $T_{J,max}$
- 3. Starting  $T_J = 25^{\circ}C$

### **Thermal Characteristics**

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Offics
Thermal resistance, junction-to-case	$R_{ heta$ JC			0.45	0.59	°C/W













# Electrical Characteristics (T<sub>J</sub> = +25°C unless otherwise specified)

# **Typical Performance - Static**

Parameter	Symbol	Test Conditions		Unito			
	Зуппрог		Min	Тур	Max	Units	
Drain-source breakdown voltage	BV <sub>DS</sub>	$V_{GS}=0V, I_D=1mA$	1200			V	
Total drain leakage current		V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C		0.5	75	^	
	I <sub>DSS</sub>	V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =175°C		7	μΑ		
Total gate leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, T <sub>J</sub> =25°C, V <sub>GS</sub> =-20V / +20V		6	±20	μΑ	
Drain-source on-resistance	R <sub>DS(on)</sub>	$V_{GS}$ =12V, $I_{D}$ =20A, $T_{J}$ =25°C		70	90	mΩ	
		V <sub>GS</sub> =12V, I <sub>D</sub> =20A, T <sub>J</sub> =175°C		148		11152	
Gate threshold voltage	V <sub>G(th)</sub>	$V_{DS}$ =5V, $I_D$ =10mA	4	5	6	V	
Gate resistance	R <sub>G</sub>	f=1MHz, open drain		4.5		Ω	

# Typical Performance - Reverse Diode

Davamatav	Symbol	Test Conditions		I India		
Parameter			Min	Тур	Max	Units
Diode continuous forward current <sup>1</sup>	I <sub>S</sub>	T <sub>C</sub> =25°C			34.5	Α
Diode pulse current <sup>2</sup>	$I_{S,pulse}$	T <sub>C</sub> =25°C			80	Α
Forward voltage	V <sub>FSD</sub>	V <sub>GS</sub> =0V, I <sub>F</sub> =10A, T <sub>J</sub> =25°C		1.41	2	. V
		V <sub>GS</sub> =0V, I <sub>F</sub> =10A, T <sub>J</sub> =175°C		1.9		
Reverse recovery charge	Q <sub>rr</sub>	$V_R$ =800V, $I_F$ =20A, $V_{GS}$ =-5V, $R_{G\_EXT}$ =18 $\Omega$		113		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=1840A/μs, T <sub>J</sub> =25°C		14		ns
Reverse recovery charge	$Q_{rr}$	$V_R$ =800V, $I_F$ =20A, $V_{GS}$ =-5V, $R_{G\_EXT}$ =18 $\Omega$		117		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=1840A/μs, Τ <sub>J</sub> =150°C		13		ns













# Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	UTILS
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V		1500		
Output capacitance	C <sub>oss</sub>	f=100kHz		114		pF
Reverse transfer capacitance	$C_{rss}$	1 100K12		2.1		
Effective output capacitance, energy related	C <sub>oss(er)</sub>	$V_{DS}$ =0V to 800V, $V_{GS}$ =0V		63	L	pF
Effective output capacitance, time related	$C_{oss(tr)}$	$V_{DS}$ =0V to 800V, $V_{GS}$ =0V		128	L	pF
C <sub>OSS</sub> stored energy	E <sub>oss</sub>	V <sub>DS</sub> =800V, V <sub>GS</sub> =0V		20	1	μJ
Total gate charge	$Q_{G}$	- V <sub>DS</sub> =800V, I <sub>D</sub> =20A, -		46		nC
Gate-drain charge	$Q_{GD}$	$V_{DS} = -5V \text{ to } 15V$		7		
Gate-source charge	$Q_{GS}$	V <sub>GS</sub> = -3V tO 13V		19		
Turn-on delay time	$t_{d(on)}$	V <sub>DS</sub> =800V, I <sub>D</sub> =20A, Gate		18	L	- ns
Rise time	t <sub>r</sub>	Driver =-5V to +15V,		33	1	
Turn-off delay time	t <sub>d(off)</sub>	Turn-on $R_{G,EXT}$ =8.2 $\Omega$ , Turn-off $R_{G,EXT}$ =18 $\Omega$ Inductive Load, FWD: same device with $V_{GS}$ = -5V, $R_{G}$ = 18 $\Omega$ , $T_{J}$ =25°C		59		
Fall time	t <sub>f</sub>			9		
Turn-on energy	E <sub>ON</sub>			449		μЈ
Turn-off energy	E <sub>OFF</sub>			23		
Total switching energy	E <sub>TOTAL</sub>			472		
Turn-on delay time	t <sub>d(on)</sub>	$V_{DS} = 800V, I_D = 20A, Gate \\ Driver = -5V to +15V, \\ Turn-on R_{G,EXT} = 8.2\Omega, \\ Turn-off R_{G,EXT} = 18\Omega \\ Inductive Load, \\ FWD: same device with \\ V_{GS} = -5V, R_G = 18\Omega, \\ T_J = 150°C$		13		
Rise time	t <sub>r</sub>			31		
Turn-off delay time	t <sub>d(off)</sub>			62		ns
Fall time	t <sub>f</sub>			8.4		
Turn-on energy	E <sub>ON</sub>			444		
Turn-off energy	E <sub>OFF</sub>			36		μЈ
Total switching energy	E <sub>TOTAL</sub>			480		





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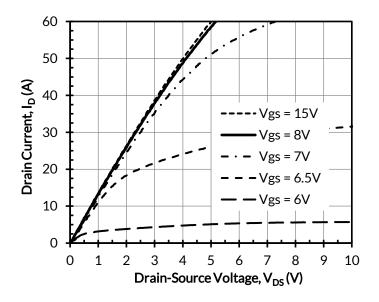








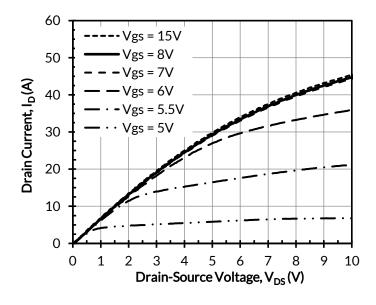
### **Typical Performance Diagrams**



50 Drain Current, I<sub>D</sub> (A) 40 30 Vgs = 15V Vgs = 8V 20 Vgs = 7VVgs = 6.5V10 Vgs = 6V10 0 1 2 Drain-Source Voltage, V<sub>DS</sub> (V)

Figure 1. Typical output characteristics at  $T_J = -55$ °C, tp < 250 $\mu$ s

Figure 2. Typical output characteristics at  $T_J = 25$ °C,  $tp < 250\mu s$ 



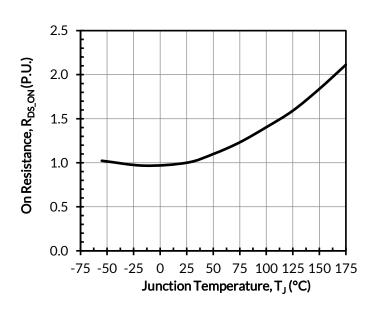


Figure 3. Typical output characteristics at  $T_J$  = 175°C, tp < 250 $\mu$ s

Figure 4. Normalized on-resistance vs. temperature at  $V_{GS}$  = 12V and  $I_D$  = 20A



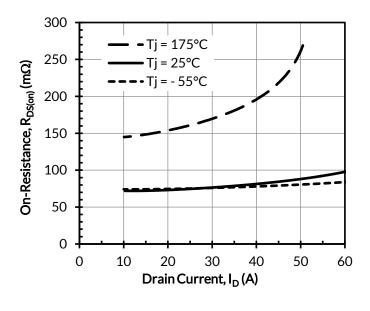








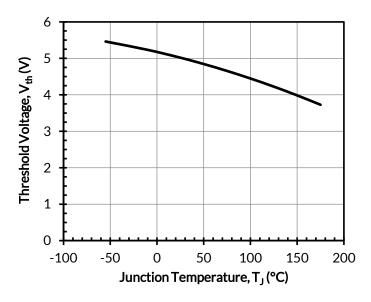




60 Tj = -55°C 50 Tj = 25°C Drain Current, I<sub>D</sub> (A) Tj = 175°C 40 30 20 10 0 3 4 5 7 8 9 0 6 10 Gate-Source Voltage,  $V_{GS}(V)$ 

Figure 5. Typical drain-source on-resistances at  $V_{\text{GS}}$  = 12V

Figure 6. Typical transfer characteristics at  $V_{DS}$  = 5V



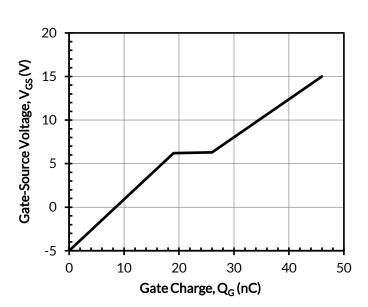


Figure 7. Threshold voltage vs. junction temperature at  $V_{DS}$  = 5V and  $I_{D}$  = 10mA

Figure 8. Typical gate charge at  $V_{DS}$  = 800V and  $I_{D}$  = 20A













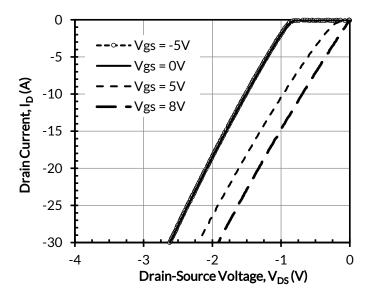
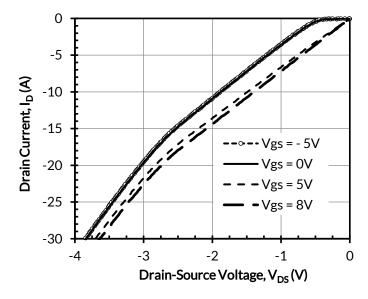


Figure 9. 3rd quadrant characteristics at  $T_J = -55$ °C

Figure 10. 3rd quadrant characteristics at  $T_J = 25$ °C



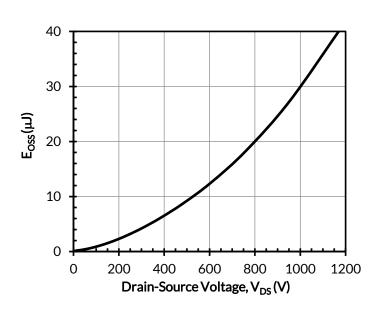


Figure 11. 3rd quadrant characteristics at  $T_J = 175$ °C

Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0V$ 



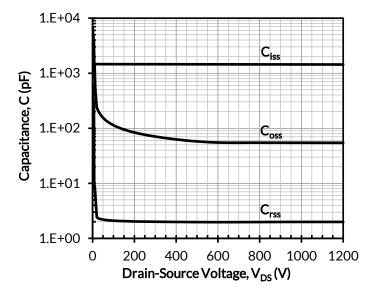








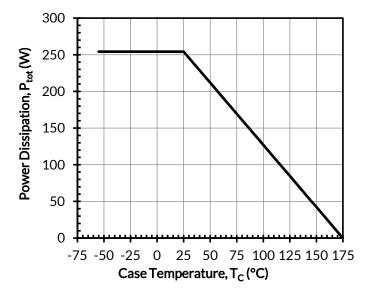




40 35 30 20 15 10 -75 -50 -25 0 25 50 75 100 125 150 175 Case Temperature, T<sub>c</sub> (°C)

Figure 13. Typical capacitances at f = 100kHz and  $V_{GS}$  = 0V

Figure 14. DC drain current derating



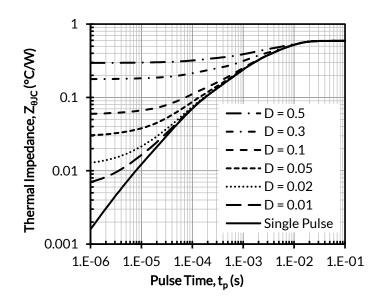


Figure 15. Total power dissipation

Figure 16. Maximum transient thermal impedance













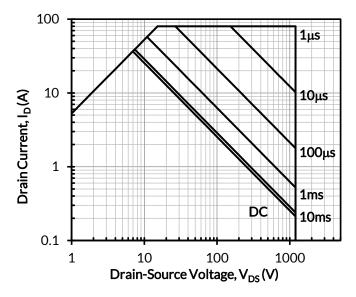


Figure 17. Safe operation area at  $T_C = 25$ °C, D = 0, Parameter  $t_p$ 

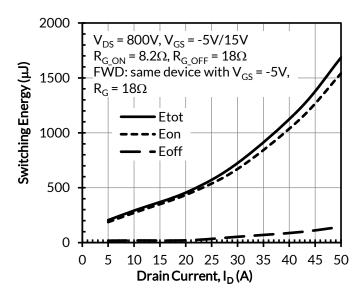


Figure 18. Clamped inductive switching energy vs. drain current at  $T_1 = 25$ °C

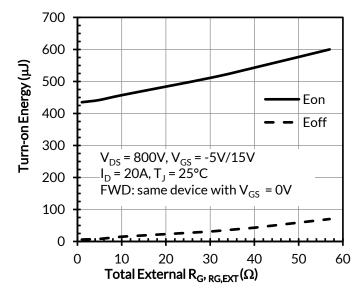


Figure 19. Clamped inductive switching turn-on energy vs.  $R_{\text{G,EXT}}\,$ 

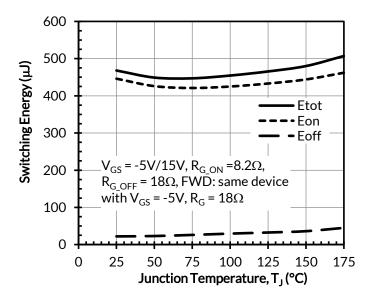


Figure 20. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  = 800V and  $I_D$  = 20A













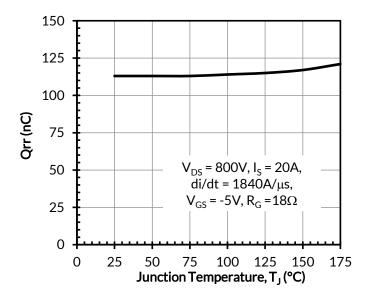


Figure 21. Reverse recovery charge Qrr vs. junction temperature

### **Applications Information**

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_G$ ), and reverse recovery charge ( $Q_G$ ) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

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